



# 제 30회 한국반도체학술대회

The 30th Korean Conference on Semiconductors

2023년 2월 13일(월) ~ 15일(수) | 강원도 하이원리조트(그랜드호텔 컨벤션타워)

2023년 2월 14일(화), 09:00-10:45

Room A (에메랄드 I, 5층)

## D. Thin Film Process Technology 분과

### [TA1-D] Metallic Films

좌장: 김성근 책임연구원(한국과학기술연구원), 엄태용 임연구원(한국화학연구원)

TA1-D-1 09:00-09:30 [초청]	반도체 소자에서 구리 범프와 절연 고분자의 하이브리드 본딩 심영주, 김한글, 황경석, 김주영 울산과학기술원 신소재공학과
TA1-D-2 09:30-09:45	<b>Molybdenum Carbide Thin Films Deposited by Thermal Atomic Layer Deposition Method under Thermal Decomposition of Mo Precursor</b> Min-Ji Ha, Jeong-Hun Choi, and Ji-Hoon Ahn <i>Department of Materials Science and Chemical Engineering, Hanyang University</i>
TA1-D-3 09:45-10:00	<b>Composition and Work Function Tuning of Plasma-enhanced Atomic-layer Deposited MoC<sub>x</sub>N<sub>y</sub> Films</b> Ji Sang Ahn, Wangu Kang, and Jeong Hwan Han <i>Department of Materials Science and Engineering, Seoul National University of Science and Technology</i>
TA1-D-4 10:00-10:15	<b>Modified Atomic Layer Deposition of Low-resistivity Molybdenum Carbide and Nitride Electrode for Next Generation DRAM Capacitor</b> Wangu Kang, Ji Sang Ahn, and Jeong Hwan Han <i>Department of Materials Science and Engineering, Seoul National University of Science and Technology</i>
TA1-D-5 10:15-10:30	<b>Atomic Layer Etching of Ruthenium Films with Organic Precursor</b> Jeongbin Lee, Jung-Tae Kim, and Woo-Hee Kim <i>Department of Materials Science and Chemical Engineering, Hanyang University</i>
TA1-D-6 10:30-10:45	<b>Growth Characteristics of Atomic Layer Deposited Iridium Thin Films with TICP and Oxygen</b> Hong Keun Chung <sup>1,2</sup> , Tae Joo Park <sup>2</sup> , and Seong Keun Kim <sup>1,3</sup> <sup>1</sup> Electronic Materials Research Center, KIST, <sup>2</sup> Department of Materials Science and Chemical Engineering, Hanyang University, <sup>3</sup> KU-KIST Graduate School of Converging Science and Technology, Korea University